Search Notes		
		ı
		ı
		l
		۱

Application/Contro	ol No. Applicant(s)/Patent Reexamination	under
10/779,842	KIM ET AL.	
Examiner	Art Unit	
James A. Dudek	2871	

	SEARCHED		
Class	Subclass	Date	Examiner
349	153,156	7/22/2005	JAD
		_	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			:

SEARCH NO' (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
	-	